

March 2013

FDPF13N50FT

N-Channel UniFETTM FRFET[®] MOSFET 500 V, 12 A, 540 m Ω

Features

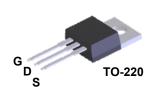
- $R_{DS(on)}$ = 420 Ω (Typ.) @ V_{GS} = 10 V, I_D = 6 A
- Low Gate Charge (Typ. 30 nC)
- Low C_{rss} (Typ. 14.5 pF)
- · 100% Avalanche Tested
- · Improved dv/dt Capability
- · RoHS Compliant

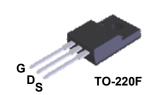
Applications

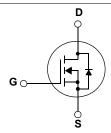
- LCD/LED/PDP TV
- Lighting
- · Uninterruptible Power Supply

Description

UniFETTM MOSFET is Fairchild Semiconductor[®]'s high voltage MOSFET family based on planar stripe and DMOS technology. This MOSFET is tailored to reduce on-state resistance, and to provide better switching performance and higher avalanche energy strength. The body diode's reverse recovery performance of UniFET FRFET[®] MOSFET has been enhanced by lifetime control. Its t_{rr} is less than 100nsec and the reverse dv/dt immunity is 15V/ns while normal planar MOSFETs have over 200nsec and 4.5V/nsec respectively. Therefore, it can remove additional component and improve system reliability in certain applications in which the performance of MOSFET's body diode is significant. This device family is suitable for switching power converter applications such as power factor correction (PFC), flat panel display (FPD) TV power, ATX and electronic lamp ballasts.







MOSFET Maximum Ratings T_C = 25°C unless otherwise noted*

Symbol	Parameter			FDPF13N50FT	Unit
V _{DSS}	Drain to Source Voltage			500	V
V _{GSS}	Gate to Source Voltage			±30	V
	Drain Current	- Continuous (T _C = 25°C)		12*	Δ.
ID	Drain Current	- Continuous (T _C = 100°C)		7.2*	Α
I _{DM}	Drain Current	- Pulsed	- Pulsed (Note 1)		Α
E _{AS}	Single Pulsed Avalanche En	nergy	(Note 2)	684	mJ
I _{AR}	Avalanche Current		(Note 1)	12	Α
E _{AR}	Repetitive Avalanche Energ	у	(Note 1)	19.5	mJ
dv/dt	Peak Diode Recovery dv/dt		(Note 3)	20	V/ns
D	Dawar Dissination	$(T_C = 25^{\circ}C)$		42	W
P_{D}	Power Dissipation	- Derate above 25°C		0.33	W/°C
T _J , T _{STG}	Operating and Storage Tem	perature Range		-55 to +150	°C
T _L	Maximum Lead Temperature 1/8" from Case for 5 Second	• •		300	°C

^{*}Drain current limited by maximum junction temperature

Thermal Characteristics

Symbol	Parameter	FDPF13N50FT	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max	3.0	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient, Max	62.5	*C/VV

Package Marking and Ordering Information T_C = 25°C unless otherwise noted

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDPF13N50FT	FDPF13N50FT	TO-220F	-	-	50

Electrical Characteristics

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
Off Charac	cteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250\mu A$, $V_{GS} = 0V$, $T_J = 25^{\circ}C$	500	-	-	V
ΔBV _{DSS} ΔΤ _J	Breakdown Voltage Temperature Coefficient	I _D = 250μA, Referenced to 25°C	-	0.7	-	V/°C
	Zero Gate Voltage Drain Current	V _{DS} = 500V, V _{GS} = 0V	-	-	10	
IDSS	Zero Gate voltage Drain Current	$V_{DS} = 400V, T_C = 125^{\circ}C$	-	-	100	μΑ
I _{GSS}	Gate to Body Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$	-	-	±100	nA

On Characteristics

V _{GS(th)}	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	3.0	-	5.0	V
R _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 10V, I_D = 6A$	-	0.42	0.54	Ω
9 _{FS}	Forward Transconductance	$V_{DS} = 20V, I_{D} = 6A$	-	13.3	-	S

Dynamic Characteristics

C _{iss}	Input Capacitance	V _{DS} = 25V, V _{GS} = 0V f = 1MHz		1450	1930	pF
C _{oss}	Output Capacitance			198	265	pF
C _{rss}	Reverse Transfer Capacitance	-1 - 11VII 12	-	14.5	22	pF
Q _{g(tot)}	Total Gate Charge at 10V		-	30	39	nC
Q_{gs}	Gate to Source Gate Charge	$V_{DS} = 400V, I_{D} = 13A$	-	8	-	nC
Q _{gd}	Gate to Drain "Miller" Charge	$V_{GS} = 10V$ (Note 4)	1	12	-	nC

Switching Characteristics

t _{d(on)}	Turn-On Delay Time			-	28	65	ns
t _r	Turn-On Rise Time	$V_{DD} = 250V, I_D = 13A$		-	54	120	ns
t _{d(off)}	Turn-Off Delay Time	$R_G = 25\Omega$		-	75	160	ns
t _f	Turn-Off Fall Time		(Note 4)	-	47	105	ns

Drain-Source Diode Characteristics

I _S	Maximum Continuous Drain to Source Diode Forward Current		-	-	12	Α
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current		-	-	48	Α
V_{SD}	Drain to Source Diode Forward Voltage	V _{GS} = 0V, I _{SD} = 12A	-	-	1.5	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0V, I _{SD} = 12A	-	154	-	ns
Q _{rr}	Reverse Recovery Charge	$dI_F/dt = 100A/\mu s$	-	0.45	-	μС

Notos

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. L = 9.5mH, I_{AS} = 12A, V_{DD} = 50V, R_{G} = 25 Ω , Starting T_{J} = 25 $^{\circ}$ C
- 3. $I_{SD} \le$ 12A, di/dt \le 200A/ μ s, $V_{DD} \le$ BV $_{DSS}$, Starting T_J = 25°C
- 4. Essentially Independent of Operating Temperature Typical Characteristics

Typical Performance Characteristics

Figure 1. On-Region Characteristics

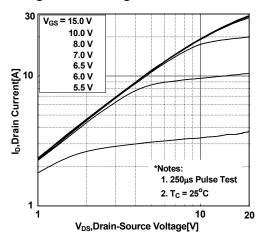


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

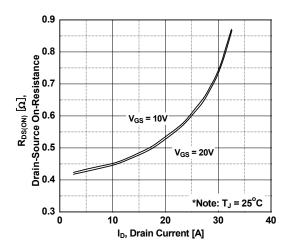


Figure 5. Capacitance Characteristics

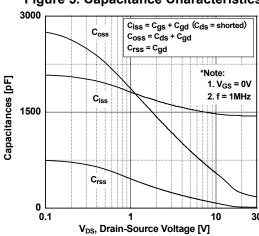


Figure 2. Transfer Characteristics

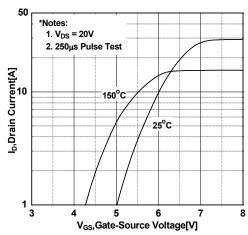


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

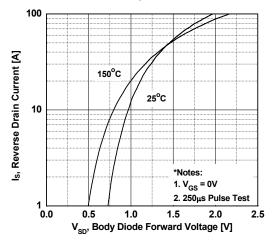
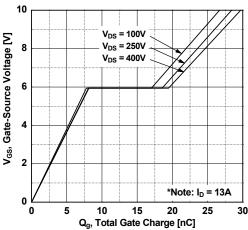


Figure 6. Gate Charge Characteristics



Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

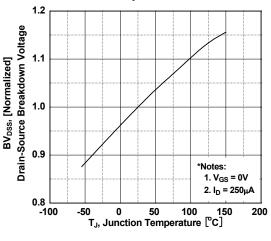


Figure 8. Maximum Safe Operating Area - FDPF13N50FT

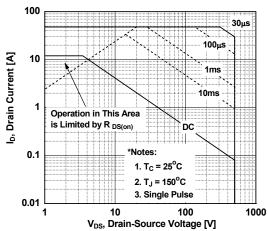


Figure 9. Maximum Drain Current vs. Case Temperature

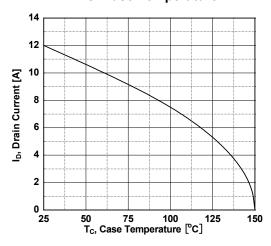
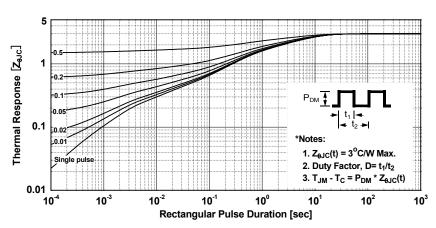
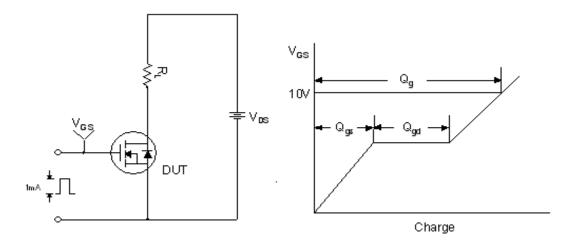


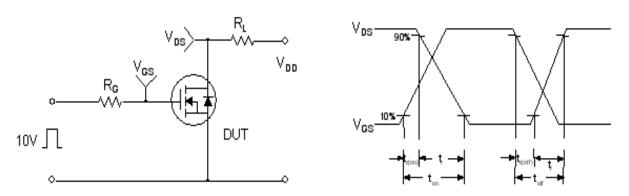
Figure 10. Transient Thermal Response Curve - FDPF13N50FT



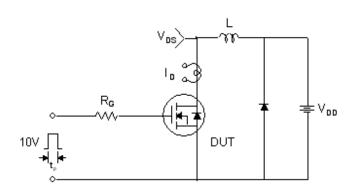
Gate Charge Test Circuit & Waveform

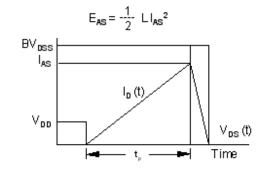


Resistive Switching Test Circuit & Waveforms

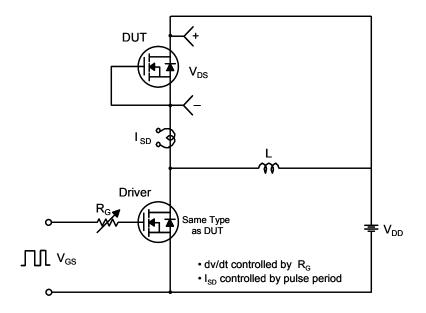


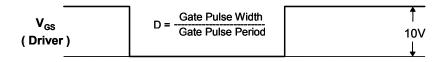
Unclamped Inductive Switching Test Circuit & Waveforms

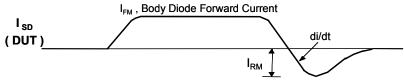




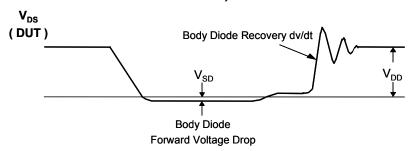
Peak Diode Recovery dv/dt Test Circuit & Waveforms





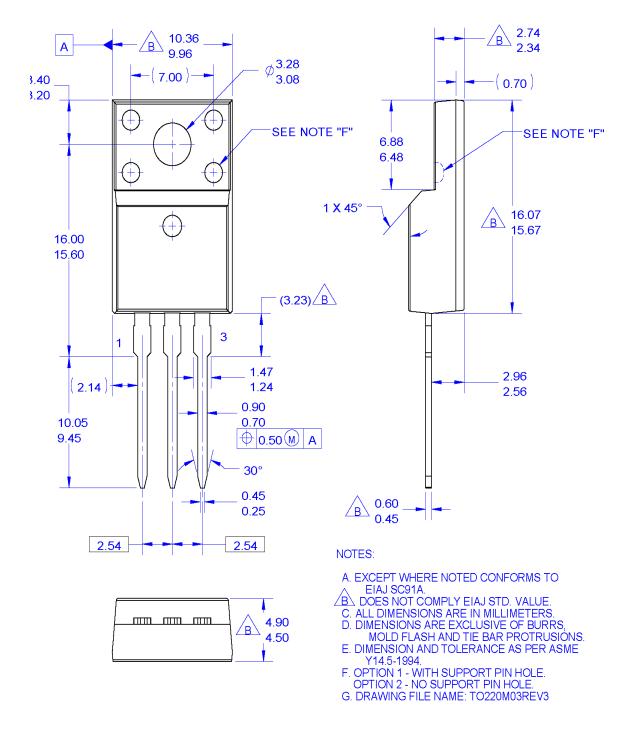


Body Diode Reverse Current



Package Dimensions

TO-220M03







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